

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

James Samsouondar

Examiner: Hien Xuan VO

Group Art Unit: 2863

Continuation of Application

No.: 09/875,143 filed June 7, 2001

Filed: Herewith

For: METHOD FOR CALIBRATING  
SPECTROPHOTOMETRIC APPARATUS

Commissioner for Patents

P. O. Box 1450

Alexandria, Virginia 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. § 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Because the documents were previously provided in application no. 09/875,143, from which the present application claims the benefit of priority under 35 U.S.C. §120, no copies of the listed documents are being provided.

In accordance with 37 CFR 1.97(h), this Information Disclosure Statement is not to be construed as an admission that the information cited is, or is considered to be, material to the patentability as defined in 37 CFR 1.56(b).

### CONCLUSION

It is respectfully requested that the below-listed information be considered by the Examiner and that an initialed copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our Washington, D.C. office by telephone at (202) 625-3500. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

A handwritten signature in cursive script, reading "Dawn C. Hayes", is written over a horizontal line.

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FORM PTO 1449 U.S. PATENT AND TRADEMARK OFFICE  <b>LIST OF REFERENCES CITED BY APPLICANTS(S)</b>					ATTORNEY DOCKET NO.		APPLICATION NO.	
					213202.00498		Continuation of 09/875,143	
					APPLICANT			
					<b>James Samsoondar</b>			
					FILING DATE		GROUP	
<b>March 22, 2004</b>		<b>2863</b>						
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		4,866,644	9/1989	Shenk et al.	364	571.02		
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION OR ABSTRACT	
		WO/98/39634	9/1998	PCT				
		WO 98/38961	9/1998	PCT				
		WO 97/47972	12/1997	PCT				
		WO 94/08225	4/1994	PCT				
<b>OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, etc.)</b>								
	Martinek, Robert G., "Liquid Absorbance Standards for Ultraviolet, Visible, and Near Infrared Spectrophotometry" <u>J. AMER. MED. TECHNOL.</u> , Vol. 40 (1978) pp. 210-216							
	Ozdemir, et al., "Hybrid Calibration Models: An Alternative to Calibration Transfer" <u>APPLIED SPECTROSCOPY</u> , Vol. 52, No. 4 (1998) pp 599-603							
	Bouveresse et al., "Calibration transfer across near-infrared spectrometric instruments using Shenk's algorithm: effects of different standardisation samples" <u>ANALYTICA CHIMICA ACTA</u> , Vol. 297 (1994) pp. 405-416							
	Blank, et al., "Transfer of Near-Infrared Multivariate Calibrations without Standards" <u>ANALYTICAL CHEMISTRY</u> , Vol. 68, No. 17 (1996) pp. 2987-2995							
	Blanco, et al., "Wavelength Calibration Transfer between Diode Array UV-Visible Spectrophotometers" <u>APPLIED SPECTROSCOPY</u> , Vol. 49, No. 5 (1995) pp. 593-597							
	Wang, et al., "Multivariate Instrument Standardization" <u>ANALYTICAL CHEMISTRY</u> , Vol 63, No. 23 (1991) pp. 2750-2756							
	Gemperline, et al., "Appearance of Discontinuities in Spectra Transformed by the Piecewise Direct Instrument Standardization Procedure" <u>ANALYTICAL CHEMISTRY</u> , Vol. 68, No. 17 (1996) pp. 2913-2915							
EXAMINER				DATE CONSIDERED				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through situation if not in conformance and not considered. Include copy of this form with next communication to applicant.